
2SJ517

Silicon P Channel MOS FET
High Speed Power Switching

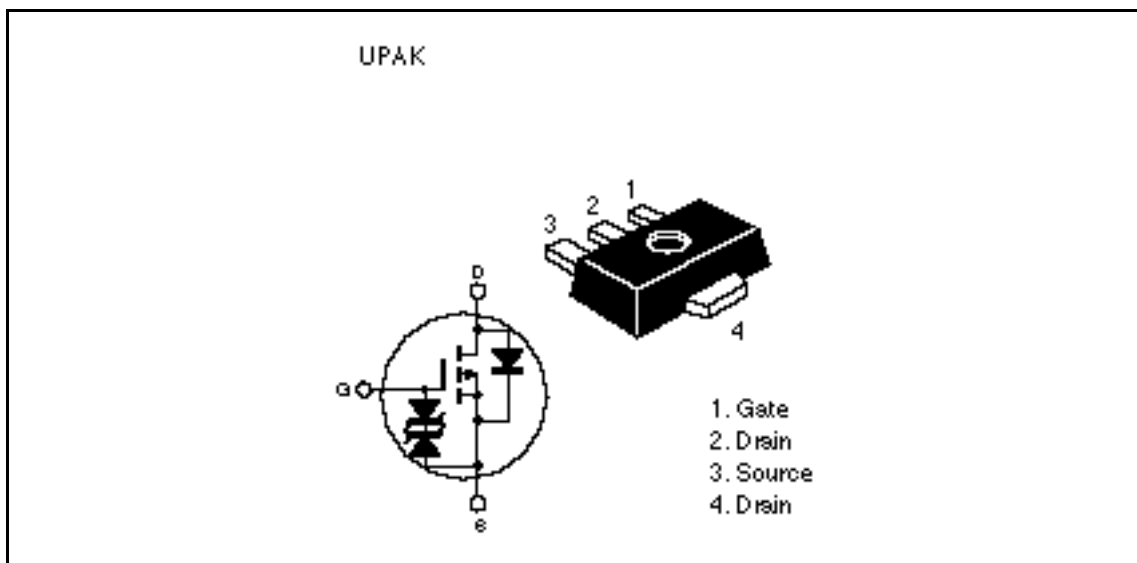
HITACHI

ADE-208-575B (Z)
3rd. Edition
Jun 1998

Features

- Low on-resistance
 $R_{DS(on)} = 0.18$ typ. (at $V_{GS} = -4V$, $I_D = -1A$)
- Low drive current
- High speed switching
- 2.5V gate drive devices.

Outline



2SJ517

Absolute Maximum Ratings (Ta = 25°C)

| Item | Symbol | Ratings | Unit |
|--|---------------------------------|-------------|------|
| Drain to source voltage | V_{DSS} | -20 | V |
| Gate to source voltage | V_{GSS} | ±10 | V |
| Drain current | I_D | -2 | A |
| Drain peak current | $I_{D(pulse)}$ ^{Note1} | -4 | A |
| Body-drain diode reverse drain current | I_{DR} | -2 | A |
| Channel dissipation | P_{ch} ^{Note2} | 1 | W |
| Channel temperature | T_{ch} | 150 | °C |
| Storage temperature | T_{stg} | -55 to +150 | °C |

Note: 1. PW 100μs, duty cycle 10 %

2. When using aluminium ceramic board (12.5 x 20 x 0.7 mm)

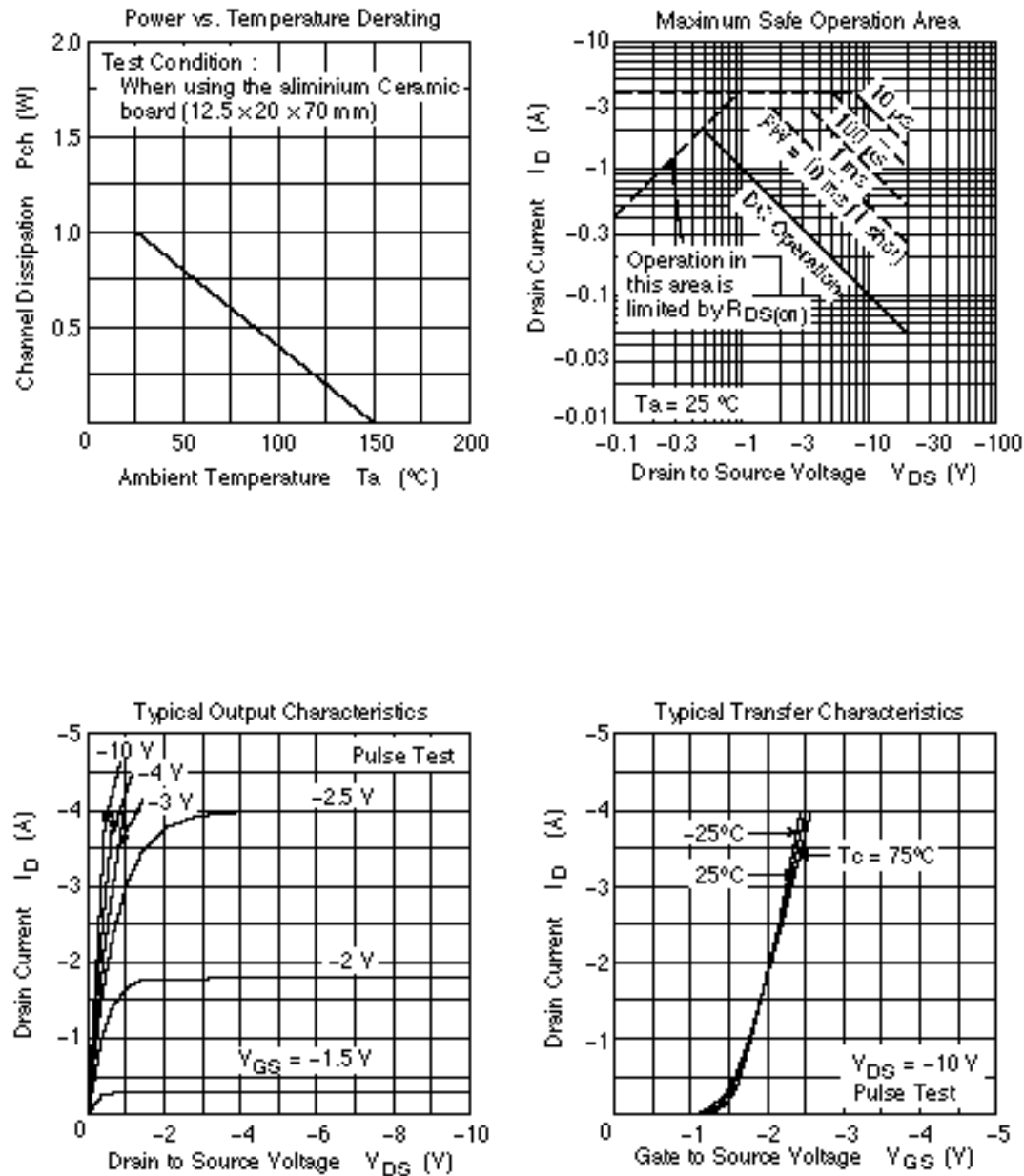
Electrical Characteristics (Ta = 25°C)

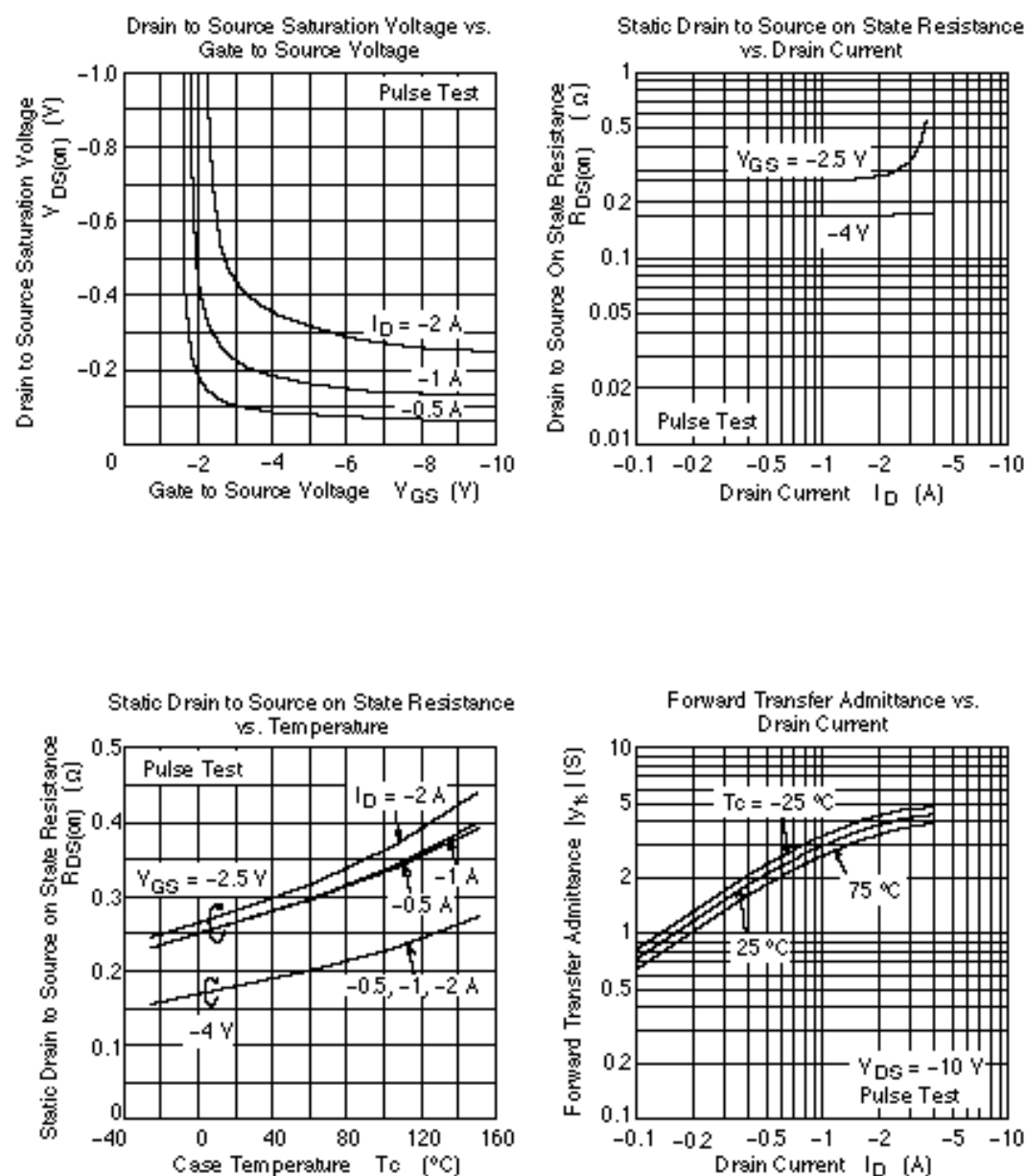
| Item | Symbol | Min | Typ | Max | Unit | Test Conditions |
|--|---------------|------|-------|------|------|--|
| Drain to source breakdown voltage | $V_{(BR)DSS}$ | -20 | — | — | V | $I_D = -10mA, V_{GS} = 0$ |
| Gate to source breakdown voltage | $V_{(BR)GSS}$ | ±10 | — | — | V | $I_G = ±100μA, V_{DS} = 0$ |
| Zero gate voltage drain current | I_{DSS} | — | — | -10 | μA | $V_{DS} = -20V, V_{GS} = 0$ |
| Gate to source leak current | I_{GSS} | — | — | ±10 | μA | $V_{GS} = ±8V, V_{DS} = 0$ |
| Gate to source cutoff voltage | $V_{GS(off)}$ | -0.5 | — | -1.5 | V | $I_D = -1mA, V_{DS} = -10V$ |
| Static drain to source on state resistance | $R_{DS(on)}$ | — | 0.18 | 0.24 | | $I_D = -1A, V_{GS} = -4V$ ^{Note3} |
| Static drain to source on state resistance | $R_{DS(on)}$ | — | 0.27 | 0.43 | | $I_D = -1A, V_{GS} = -2.5V$ ^{Note3} |
| Forward transfer admittance | $ y_{fs} $ | 1.8 | 3.0 | — | S | $I_D = -1A, V_{DS} = -10V$ ^{Note3} |
| Input capacitance | C_{iss} | — | 320 | — | pF | $V_{DS} = -10V$ |
| Output capacitance | C_{oss} | — | 190 | — | pF | $V_{GS} = 0$ |
| Reverse transfer capacitance | C_{rss} | — | 90 | — | pF | $f = 1MHz$ |
| Turn-on delay time | $t_{d(on)}$ | — | 14 | — | ns | $I_D = -1A, R_L = 10$ |
| Rise time | t_r | — | 75 | — | ns | $V_{GS} = -4V$ |
| Turn-off delay time | $t_{d(off)}$ | — | 90 | — | ns | |
| Fall time | t_f | — | 90 | — | ns | |
| Body-drain diode forward voltage | V_{DF} | — | -0.95 | — | V | $I_F = -2A, V_{GS} = 0$ |
| Body-drain diode reverse recovery time | t_{rr} | — | 70 | — | ns | $I_F = -2A, V_{GS} = 0$ $diF/dt = 50A/μs$ |

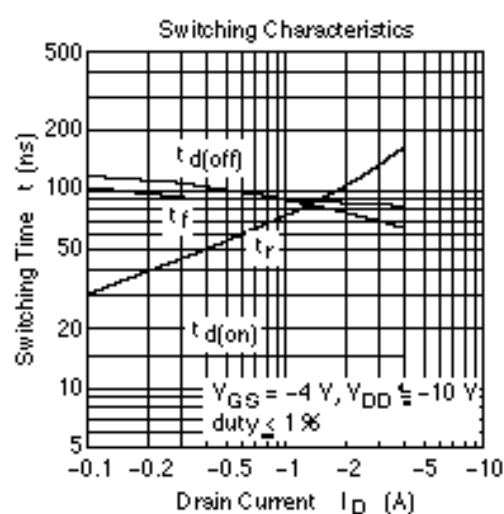
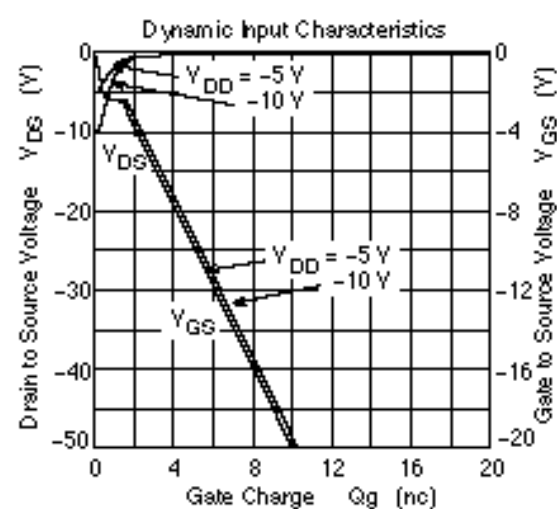
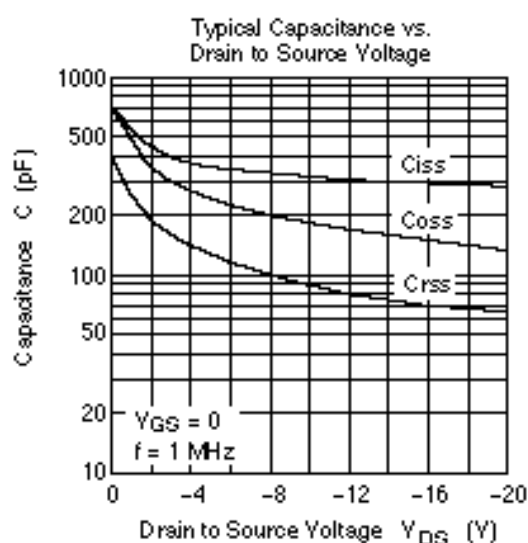
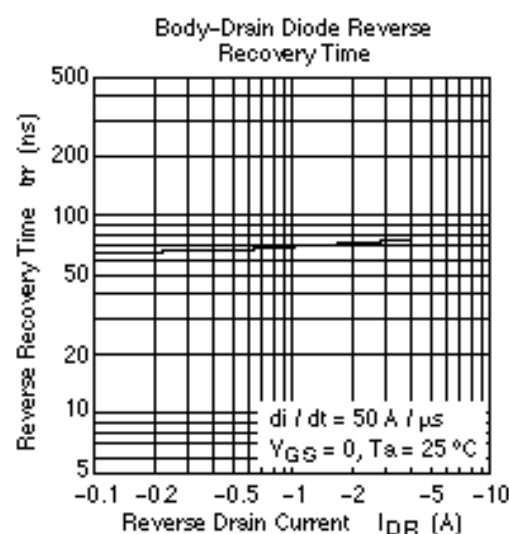
Note: 3. Pulse test

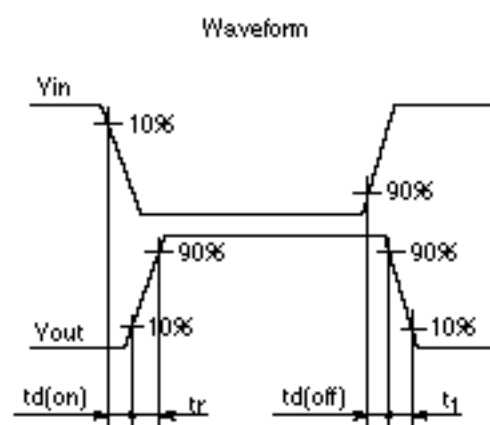
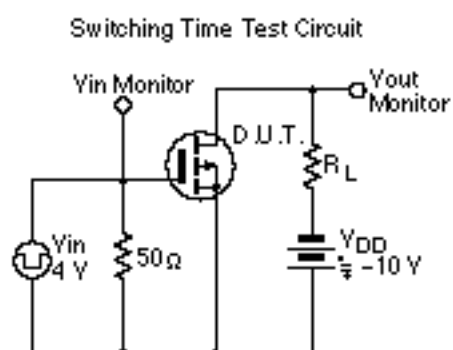
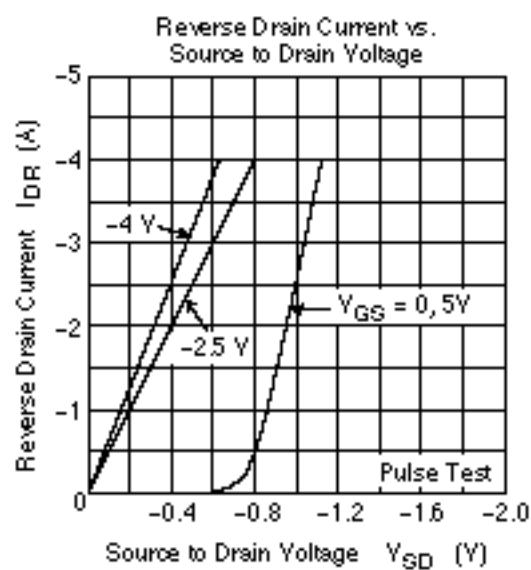
4. Marking is "YY".

Main Characteristics



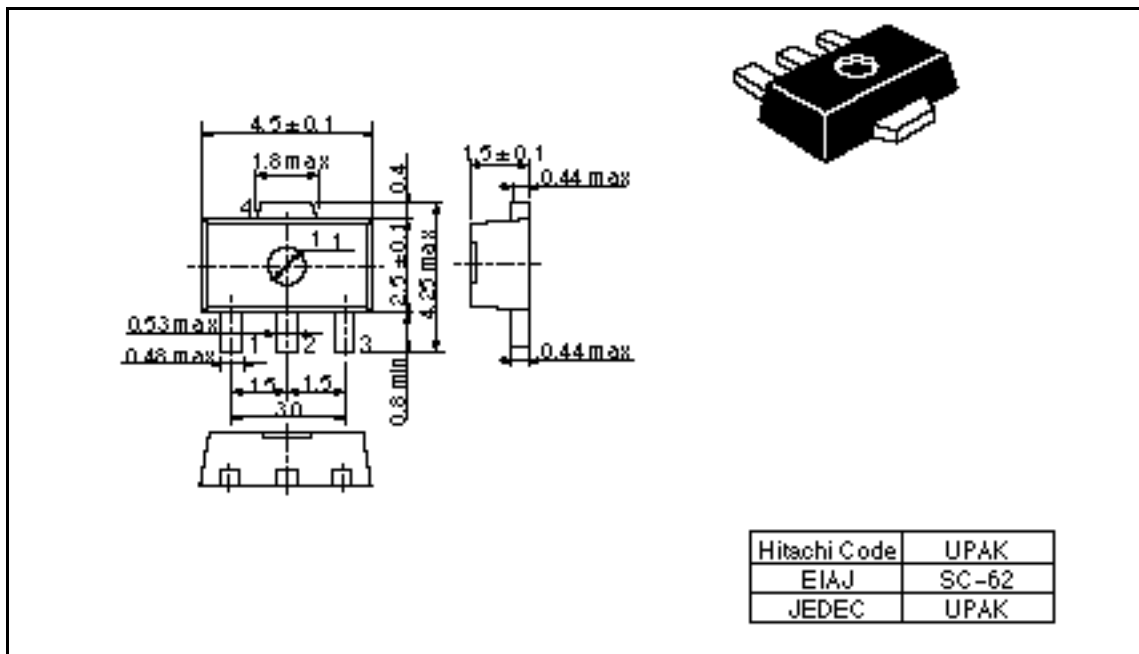






Package Dimensions

Unit: mm



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